PHD34NQ10T

N-channel TrenchMOS standard level FET

Product data sheet

1. Product profile

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

- Higher operating power due to low thermal resistance
- Low conduction losses due to low on-state resistance
- Suitable for high frequency applications due to fast switching characteristics

1.3 Applications

- DC-to-DC converters
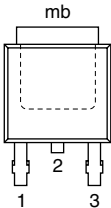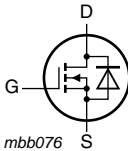- Switched-mode power supplies

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{DS}	drain-source voltage	$T_j \geq 25\ °C$; $T_j \leq 175\ °C$	-	-	100	V
I_D	drain current	$T_{mb} = 25\ °C$; $V_{GS} = 10\ V$	-	-	35	A
P_{tot}	total power dissipation	$T_{mb} = 25\ °C$	-	-	136	W
Static characteristics						
R_{DSon}	drain-source on-state resistance	$V_{GS} = 10\ V$; $I_D = 17\ A$; $T_j = 25\ °C$	-	35	40	mΩ
Dynamic characteristics						
Q_{GD}	gate-drain charge	$V_{GS} = 10\ V$; $I_D = 34\ A$; $V_{DS} = 80\ V$; $T_j = 25\ °C$	-	18	-	nC

2. Pinning information

Table 2.   Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	D	drain[1]		
3	S	source		
mb	D	mounting base; connected to drain		

SOT428 (DPAK)

[1]   It is not possible to make connection to pin 2.

3. Ordering information
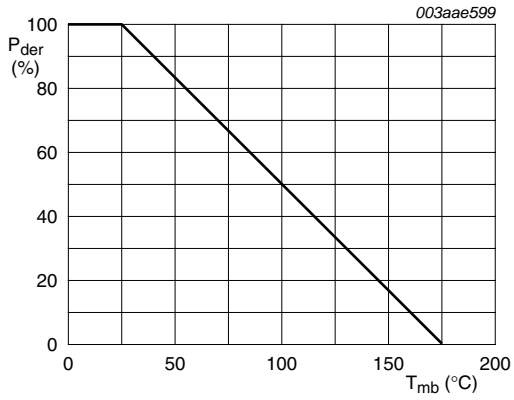
Table 3.   Ordering information

| Type number	Package		
	Name	**Description**	**Version**
PHD34NQ10T	DPAK	plastic single-ended surface-mounted package (DPAK); 3 leads (one lead cropped)	SOT428

4. Limiting values

Table 4.   Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$T_j \geq 25$ °C; $T_j \leq 175$ °C	-	100	V
V_{DGR}	drain-gate voltage	$T_j \geq 25$ °C; $T_j \leq 175$ °C; $R_{GS} = 20$ kΩ	-	100	V
V_{GS}	gate-source voltage		-20	20	V
I_D	drain current	$V_{GS} = 10$ V; $T_{mb} = 25$ °C	-	35	A
		$V_{GS} = 10$ V; $T_{mb} = 100$ °C	-	25	A
I_{DM}	peak drain current	pulsed; $T_{mb} = 25$ °C	-	140	A
P_{tot}	total power dissipation	$T_{mb} = 25$ °C	-	136	W
T_{stg}	storage temperature		-55	175	°C
T_j	junction temperature		-55	175	°C
Source-drain diode					
I_S	source current	$T_{mb} = 25$ °C	-	35	A
I_{SM}	peak source current	pulsed; $T_{mb} = 25$ °C	-	140	A
Avalanche ruggedness					
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	$V_{GS} = 10$ V; $T_{j(init)} = 25$ °C; $I_D = 26$ A; $V_{sup} \leq 25$ V; unclamped; $t_p = 100$ μs; $R_{GS} = 50$ Ω	-	170	mJ
I_{AS}	non-repetitive avalanche current	$V_{sup} \leq 25$ V; $V_{GS} = 10$ V; $T_{j(init)} = 25$ °C; $R_{GS} = 50$ Ω; unclamped	-	35	A

PHD34NQ10T

All information provided in this document is subject to legal disclaimers.

© NXP B.V. 2010. All rights reserved.

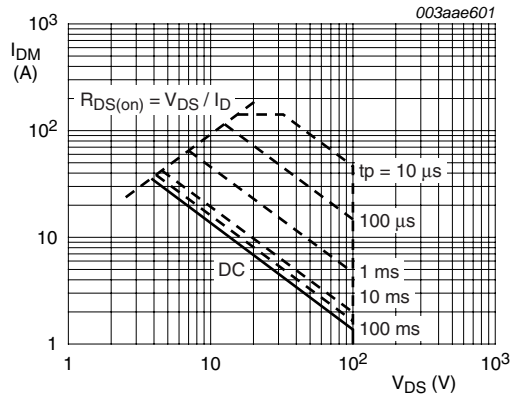**Product data sheet**

Rev. 03 — 14 December 2010

2 of 12

$$P_{der} = \frac{P_{tot}}{P_{tot(25°C)}} \times 100\%$$

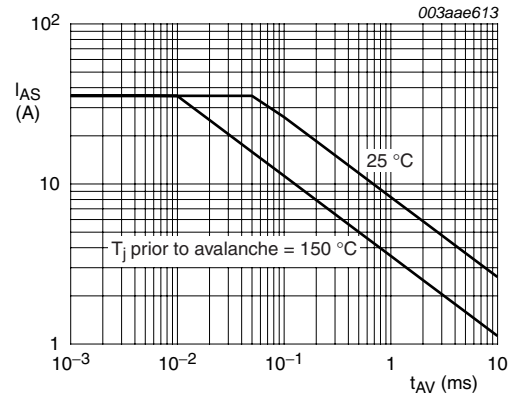**Fig 1.** Normalized total power dissipation as a function of mounting base temperature
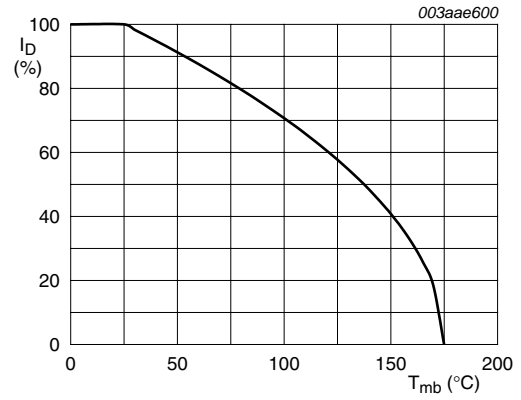
$$I_{der} = \frac{I_D}{I_{D(25°C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of mounting base temperature

$T_{mb} = 25\ °C$; I_{DM} is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

unclamped inductive load

Fig 4. Single-shot avalanche rating; avalanche current as a function of avalanche period

PHD34NQ10T

All information provided in this document is subject to legal disclaimers.

© NXP B.V. 2010. All rights reserved.

Product data sheet

Rev. 03 — 14 December 2010

3 of 12

5. Thermal characteristics

Table 5.   Thermal characteristics

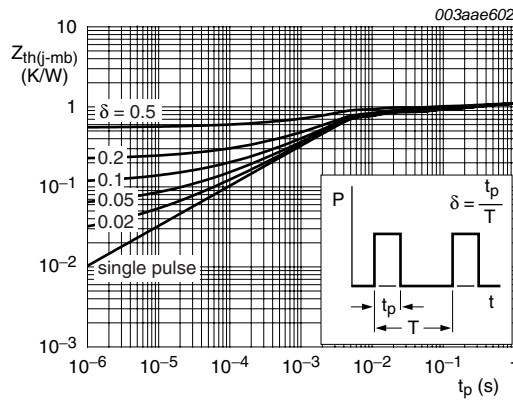| Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base		-	-	1.1	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	mounted on printed-circuit board ; minimum footprint	-	50	-	K/W

Fig 5.   Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

Table 6. **Characteristics**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	I_D = 0.25 mA; V_{GS} = 0 V; T_j = -55 °C	89	-	-	V
		I_D = 0.25 mA; V_{GS} = 0 V; T_j = 25 °C	100	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	I_D = 1 mA; V_{DS} = V_{GS}; T_j = -55 °C	-	-	4.4	V
		I_D = 1 mA; V_{DS} = V_{GS}; T_j = 175 °C	1	-	-	V
		I_D = 1 mA; V_{DS} = V_{GS}; T_j = 25 °C	2	3	4	V
I_{DSS}	drain leakage current	V_{DS} = 100 V; V_{GS} = 0 V; T_j = 175 °C	-	-	500	µA
		V_{DS} = 100 V; V_{GS} = 0 V; T_j = 25 °C	-	0.05	10	µA
I_{GSS}	gate leakage current	V_{GS} = 10 V; V_{DS} = 0 V; T_j = 25 °C	-	10	100	nA
		V_{GS} = -10 V; V_{DS} = 0 V; T_j = 25 °C	-	10	100	nA
R_{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_D = 17 A; T_j = 175 °C	-	-	108	mΩ
		V_{GS} = 10 V; I_D = 17 A; T_j = 25 °C	-	35	40	mΩ
Dynamic characteristics						
$Q_{G(tot)}$	total gate charge	I_D = 34 A; V_{DS} = 80 V; V_{GS} = 10 V; T_j = 25 °C	-	40	-	nC
Q_{GS}	gate-source charge		-	7	-	nC
Q_{GD}	gate-drain charge		-	18	-	nC
C_{iss}	input capacitance	V_{DS} = 25 V; V_{GS} = 0 V; f = 1 MHz; T_j = 25 °C	-	1704	-	pF
C_{oss}	output capacitance		-	227	-	pF
C_{rss}	reverse transfer capacitance		-	140	-	pF
$t_{d(on)}$	turn-on delay time	V_{DS} = 50 V; R_L = 1.5 Ω; V_{GS} = 10 V; $R_{G(ext)}$ = 5.6 Ω; T_j = 25 °C	-	12	-	ns
t_r	rise time		-	55	-	ns
$t_{d(off)}$	turn-off delay time		-	48	-	ns
t_f	fall time		-	38	-	ns
L_D	internal drain inductance	measured from mounting base to centre of die ; T_j = 25 °C	-	3.5	-	nH
L_S	internal source inductance	measured from source lead to source bond pad ; T_j = 25 °C	-	7.5	-	nH
Source-drain diode						
V_{SD}	source-drain voltage	I_S = 17 A; V_{GS} = 0 V; T_j = 25 °C	-	0.85	1.2	V
t_{rr}	reverse recovery time	I_S = 17 A; dI_S/dt = -100 A/µs; V_{GS} = 0 V; V_{DS} = 25 V; T_j = 25 °C	-	76	-	ns
Q_r	recovered charge		-	0.24	-	µC

PHD34NQ10T

Product data sheet

Rev. 03 — 14 December 2010
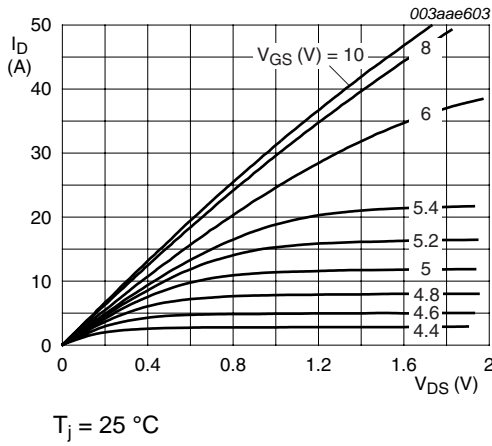
5 of 12

T$_j$ = 25 °C

Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values

T$_j$ = 25 °C
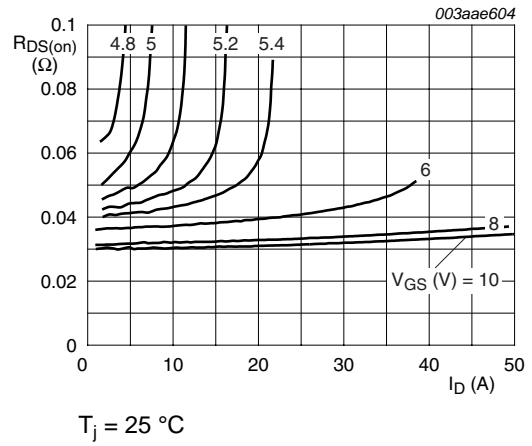
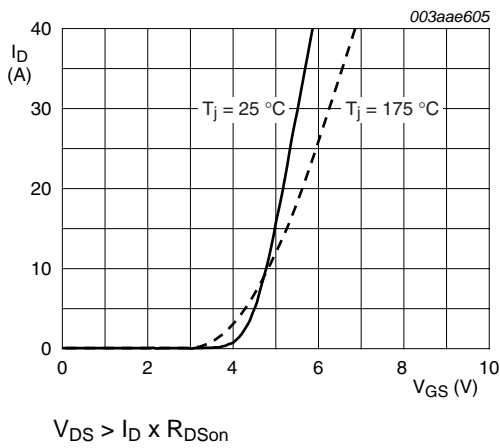**Fig 7.** Drain-source on-state resistance as a function of drain current; typical values

V$_{DS}$ > I$_D$ x R$_{DSon}$

Fig 8. Transfer characteristics: drain current as a function of gate-source voltage; typical values
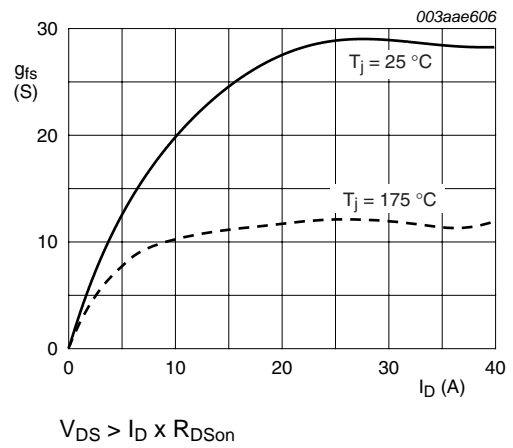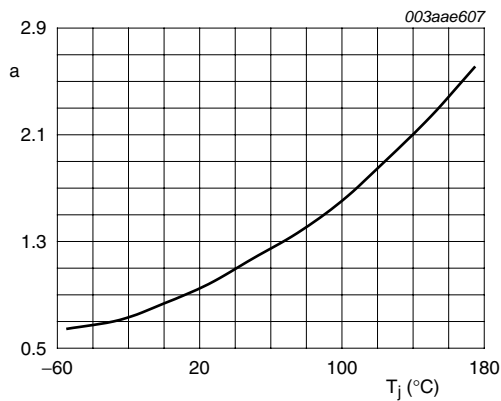

V$_{DS}$ > I$_D$ x R$_{DSon}$

Fig 9. Forward transconductance as a function of drain current; typical values

$$a = \frac{R_{DSon}}{R_{DSon(25°C)}}$$

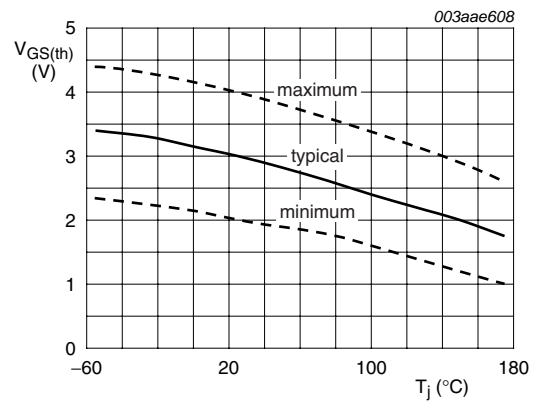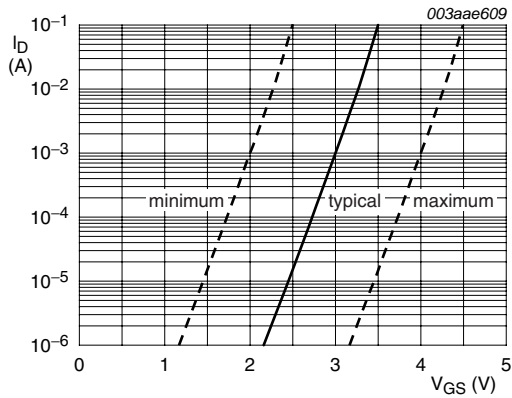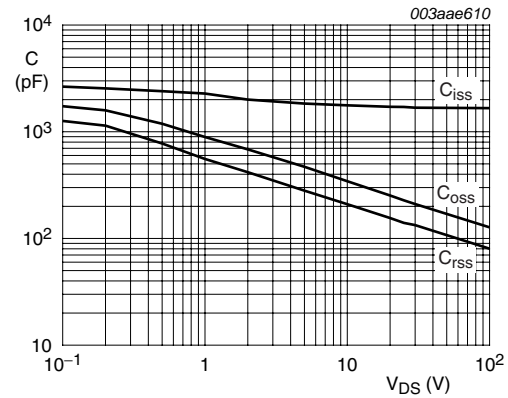**Fig 10.** Normalized drain-source on-state resistance factor as a function of junction temperature

I$_D$ = 1 mA; V$_{DS}$ = V$_{GS}$

Fig 11. Gate-source threshold voltage as a function of junction temperature

PHD34NQ10T

Product data sheet Rev. 03 — 14 December 2010 6 of 12

$T_j = 25\ °C$; $V_{DS} = V_{GS}$

Fig 12. **Sub-threshold drain current as a function of gate-source voltage**

$V_{GS} = 0\ V$; $f = 1\ MHz$

Fig 13. **Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values**
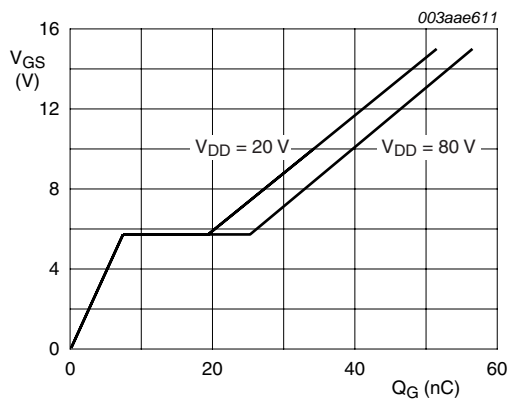
$T_j = 25\ °C$; $I_D = 34\ A$

Fig 14. **Gate-source voltage as a function of gate charge; typical values**
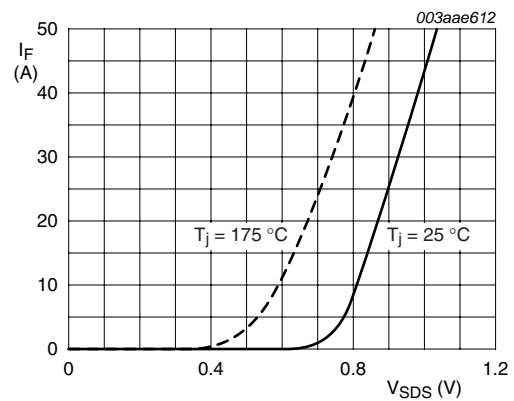
$V_{GS} = 0\ V$

Fig 15. **Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values**

PHD34NQ10T

Product data sheet **Rev. 03 — 14 December 2010** 7 of 12

7. Package outline

Plastic single-ended surface-mounted package (DPAK); 3 leads (one lead cropped) SOT428

DIMENSIONS (mm are the original dimensions)

UNIT	A	A$_1$	b	b$_1$	b$_2$	c	D$_1$	D$_2$ min	E	E$_1$ min	e	e$_1$	H$_D$	L	L$_1$ min	L$_2$	w	y max
mm	2.38 2.22	0.93 0.46	0.89 0.71	1.1 0.9	5.46 5.00	0.56 0.20	6.22 5.98	4.0	6.73 6.47	4.45	2.285	4.57	10.4 9.6	2.95 2.55	0.5	0.9 0.5	0.2	0.2

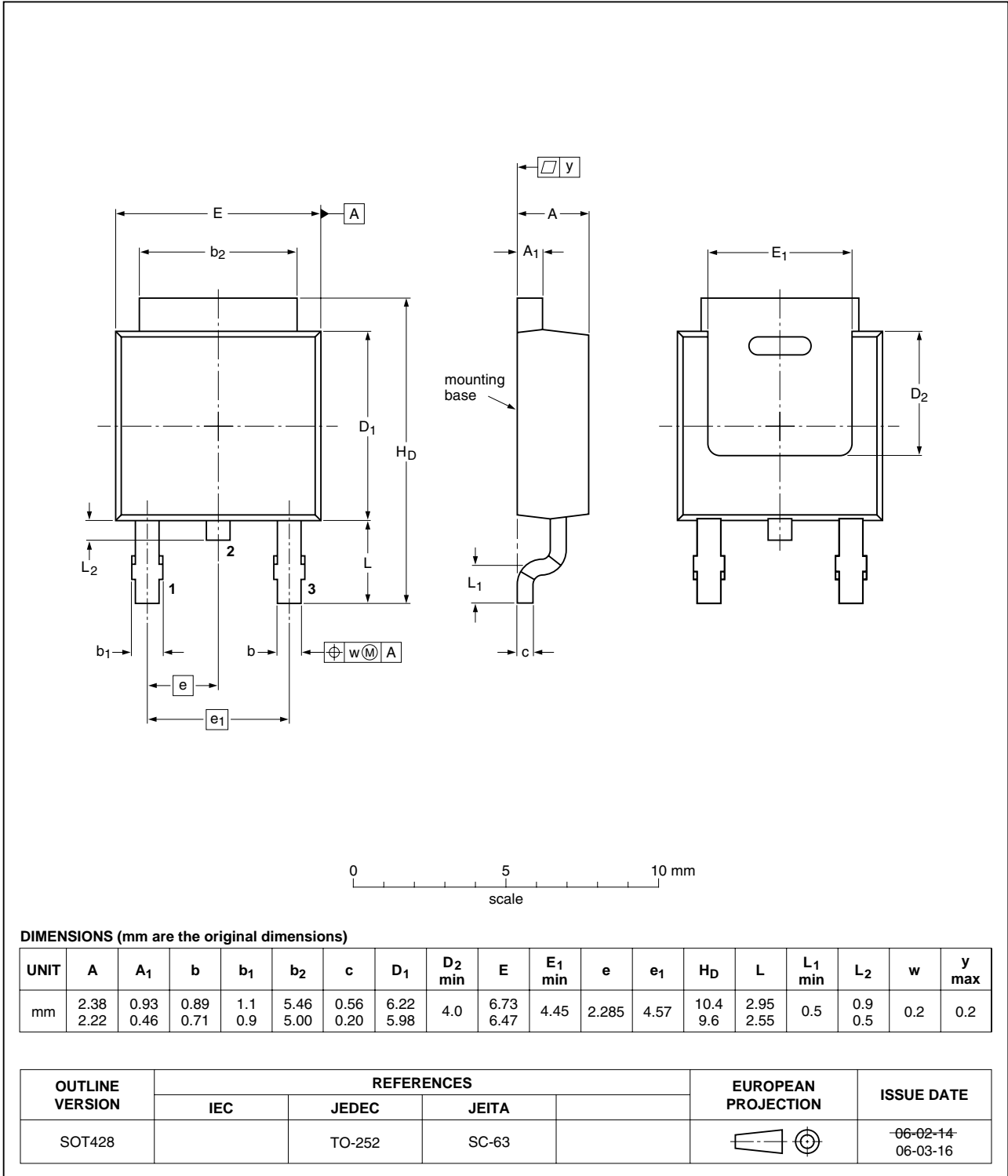| OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT428		TO-252	SC-63			~~06-02-14~~ 06-03-16

Fig 16. Package outline SOT428 (DPAK)

8. Revision history

Table 7.   Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PHD34NQ10T v.3	20101214	Product data sheet	-	PHB_PHD_PHP34NQ10T v.2
Modifications:	• The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.			
	• Legal texts have been adapted to the new company name where appropriate.			
	• Type number PHD34NQ10T separated from data sheet PHB_PHD_PHP34NQ10T v.2.			
PHB_PHD_PHP34NQ10T v.2	20031101	Product data sheet	-	PHB_PHD_PHP34NQ10T v.1

9. Legal information

9.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

9.2 Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

Product specification — The information and data provided in a Product data sheet shall define the specification of the product as agreed between NXP Semiconductors and its customer, unless NXP Semiconductors and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the NXP Semiconductors product is deemed to offer functions and qualities beyond those described in the Product data sheet.

9.3 Disclaimers

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information.

In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the *Terms and conditions of commercial sale* of NXP Semiconductors.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors accepts no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Customers are responsible for the design and operation of their applications and products using NXP Semiconductors products, and NXP Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the NXP Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using NXP Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). NXP does not accept any liability in this respect.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

Terms and conditions of commercial sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at http://www.nxp.com/profile/terms, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective

PHD34NQ10T

All information provided in this document is subject to legal disclaimers.

© NXP B.V. 2010. All rights reserved.

Product data sheet

Rev. 03 — 14 December 2010

10 of 12

agreement shall apply. NXP Semiconductors hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of NXP Semiconductors products by customer.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from national authorities.

Non-automotive qualified products — Unless this data sheet expressly states that this specific NXP Semiconductors product is automotive qualified, the product is not suitable for automotive use. It is neither qualified nor tested in accordance with automotive testing or application requirements. NXP Semiconductors accepts no liability for inclusion and/or use of non-automotive qualified products in automotive equipment or applications.

In the event that customer uses the product for design-in and use in automotive applications to automotive specifications and standards, customer (a) shall use the product without NXP Semiconductors' warranty of the

product for such automotive applications, use and specifications, and (b) whenever customer uses the product for automotive applications beyond NXP Semiconductors' specifications such use shall be solely at customer's own risk, and (c) customer fully indemnifies NXP Semiconductors for any liability, damages or failed product claims resulting from customer design and use of the product for automotive applications beyond NXP Semiconductors' standard warranty and NXP Semiconductors' product specifications.

9.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

Adelante, **Bitport**, **Bitsound**, **CoolFlux**, **CoReUse**, **DESFire**, **EZ-HV**, **FabKey**, **GreenChip**, **HiPerSmart**, **HITAG**, **I²C-bus** logo, **ICODE**, **I-CODE**, **ITEC**, **Labelution**, **MIFARE**, **MIFARE Plus**, **MIFARE Ultralight**, **MoReUse**, **QLPAK**, **Silicon Tuner**, **SiliconMAX**, **SmartXA**, **STARplug**, **TOPFET**, **TrenchMOS**, **TriMedia** and **UCODE** — are trademarks of NXP B.V.

HD Radio and **HD Radio** logo — are trademarks of iBiquity Digital Corporation.

10. Contact information

For more information, please visit: http://www.nxp.com

For sales office addresses, please send an email to: salesaddresses@nxp.com

PHD34NQ10T

All information provided in this document is subject to legal disclaimers.

© NXP B.V. 2010. All rights reserved.

Product data sheet

Rev. 03 — 14 December 2010

11 of 12

11. Contents

Date of release: 14 December 2010
Document identifier: PHD34NQ10T

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET *category:*

Click to view products by NXP *manufacturer:*

Other Similar products are found below :

614233C 648584F MCH3443-TL-E MCH6422-TL-E FDPF9N50NZ FW216A-TL-2W FW231A-TL-E APT5010JVR NTNS3A92PZT5G IRF100S201 JANTX2N5237 2SK2464-TL-E 2SK3818-DL-E FCA20N60_F109 FDZ595PZ STD6600NT4G FSS804-TL-E 2SJ277-DL-E 2SK1691-DL-E 2SK2545(Q,T) D2294UK 405094E 423220D MCH6646-TL-E TPCC8103,L1Q(CM 367-8430-0972-503 VN1206L 424134F 026935X 051075F SBVS138LT1G 614234A 715780A NTNS3166NZT5G 751625C 873612G IRF7380TRHR IPS70R2K0CEAKMA1 RJK60S3DPP-E0#T2 RJK60S5DPK-M0#T0 APT5010JVFR APT12031JFLL APT12040JVR DMN3404LQ-7 NTE6400 JANTX2N6796U JANTX2N6784U JANTXV2N5416U4 SQM110N05-06L-GE3 SIHF35N60E-GE3